

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 09/851,645 | Applicant(s)/Patent Under Reexamination BANTZ ET AL. | |
| | Examiner Yasin M Barqadle | Art Unit 2153 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| | A | US-6,654,783 B1 | 11-2003 | Hubbard, Edward A. | 709/202 |
| | B | US-6,009,455 A | 12-1999 | Doyle, John F. | 709/201 |
| | C | US-5,559,960 A | 09-1996 | Lettvin, Jonathan D. | 713/200 |
| | D | US-6,438,553 | 08-2002 | Yamada, Kazuo | 707/10 |
| | E | US-6,711,616 | 03-2004 | Stamm et al. | 709/226 |
| | F | US-6,728,751 B1 | 04-2004 | Cato et al. | 709/202 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.